

# MI8631-VB Datasheet Dual P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)		
- 30	0.038 at V <sub>GS</sub> = - 10 V	- 6.4		
- 30	0.060 at V <sub>GS</sub> = - 4.5 V	- 5		

# 3.30 mm 3.30 mm 2 3.30 mm 1 2 3.30 mm

**Bottom View** 

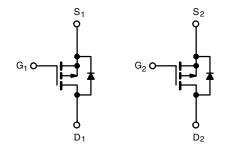
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Available
- Trench Power MOSFET
- New Low Thermal Resistance Power Package



#### **APPLICATIONS**

- Portable
  - Battery Switch
  - Load Switch



P-Channel MOSFET

P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_{A}$	= 25 °C, unles	s otherwise n	oted			
Parameter		Symbol	10 s	Steady State	Unit	
Drain-Source Voltage		V <sub>DS</sub>	- 30			
Gate-Source Voltage		V <sub>GS</sub>	± 20		V	
Out in the Darie Out of the 150 2008	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	- 6.4	- 4.3		
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>A</sub> = 85 °C		- 4.6	- 3.1		
Pulsed Drain Current		I <sub>DM</sub>	- 20		Α	
Continuous Source Current (Diode Conduction) <sup>a</sup>		I <sub>S</sub>	- 2.3	- 1.1		
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.8	1.3	W	
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 85 °C	' D	1.5	0.85	VV	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		°C	
Soldering Recommendations (Peak Temperature) <sup>b, c</sup>			260			

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Marrian una lumation de Ambienta	t ≤ 10 s	R <sub>thJA</sub>	35	44	
Maximum Junction-to-Ambient <sup>a</sup>	Steady State	' 'thJA	75	94	°C/W
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	4	5	

#### Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. The DFN3x3 package is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- c. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.



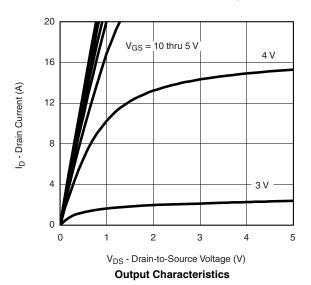
Parameter	1	unless otherwise noted  Symbol Test Conditions			Max.	Unit
	Symbol	rest conditions	Min.	Тур.	wax.	Unit
Static	1				1	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.0		- 3.0	٧
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$		- 1	^	
Zero Gate Voltage Drain Current	טאטי	$V_{DS}$ = - 30 V, $V_{GS}$ = 0 V, $T_J$ = 55 °C			- 5	μΑ
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 20			Α
Orain-Source On-State Resistance	D	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 6.4 A		0.038		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 5 A		0.060		Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 6.4 A		13		S
Diode Forward Voltage <sup>a</sup>	$V_{SD}$	I <sub>S</sub> = - 2.3 A, V <sub>GS</sub> = 0 V		- 0.8	- 1.2	V
Dynamic <sup>b</sup>			•	•		
Total Gate Charge	$Q_g$			14	21	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -6.4 \text{ A}$		2.4		nC
Gate-Drain Charge	$Q_{gd}$			3.8		
Gate Resistance	$R_{g}$			8.5		Ω
Turn-On Delay Time	t <sub>d(on)</sub>			10	15	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 15 $\Omega$		12	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ - 1 A, $V_{GEN}$ = - 10 V, $R_g$ = 6 $\Omega$		38	60	ns
Fall Time	t <sub>f</sub>			28	45	
Source-Drain Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = - 2.3 A, dI/dt = 100 A/μs		20	40	

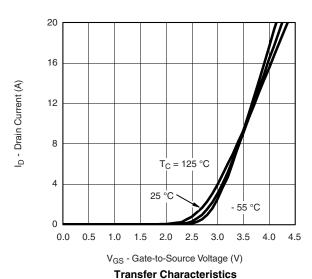
#### Notes:

- a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

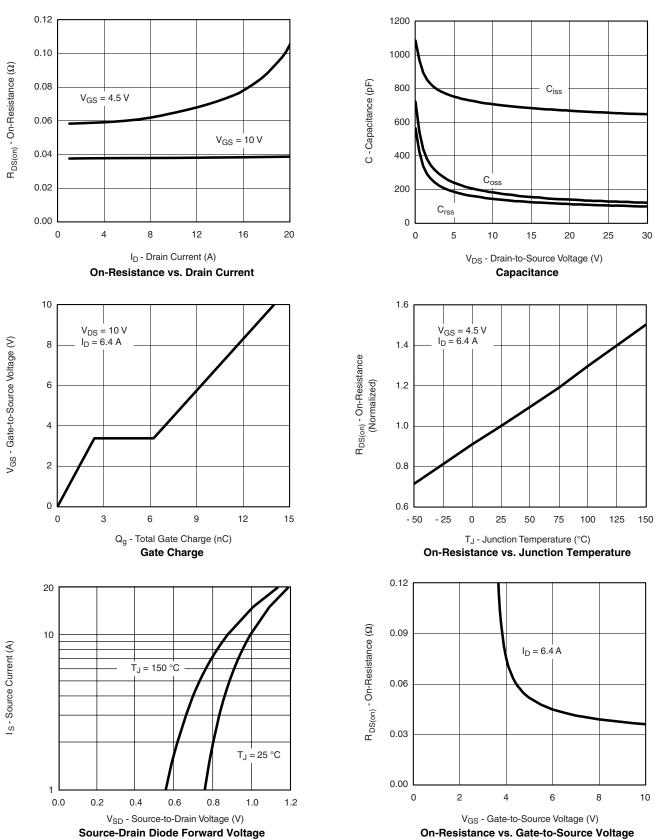
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





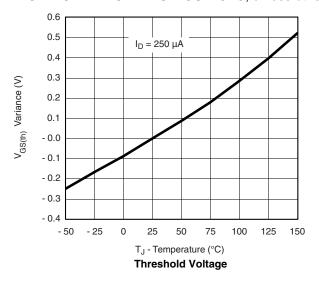


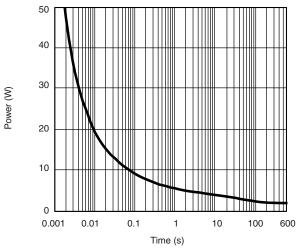
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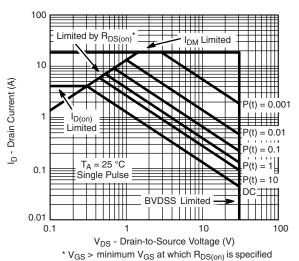


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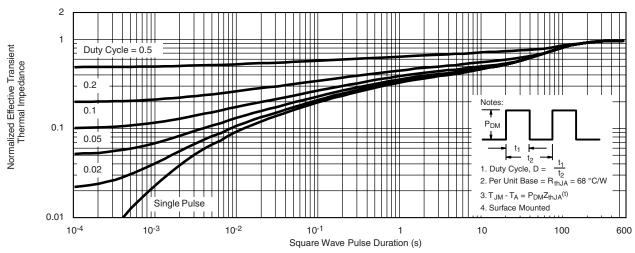




Single Pulse Power, Junction-to-Ambient



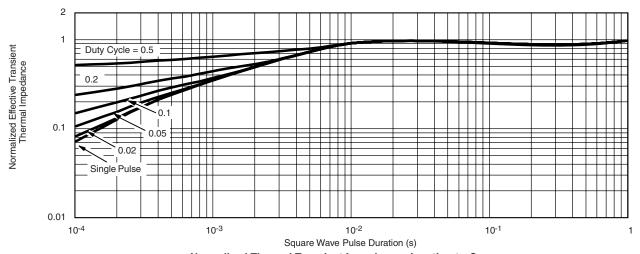
Safe Operating Area, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Ambient



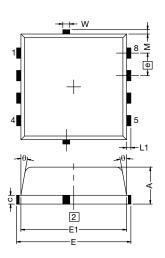
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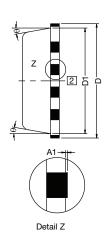


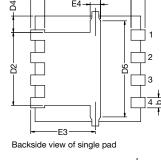
Normalized Thermal Transient Impedance, Junction-to-Case

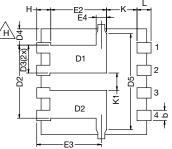


# DFN3x3, (Single / Dual)









Backside view of dual pad

#### Notes

Inch will govern
 Dimensions exclusive of mold gate burrs
 Dimensions exclusive of mold flash and cutting burrs

MILLIMETERS	INCHES

DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.97	1.04	1.12	0.038	0.041	0.044	
A1	0.00	=	0.05	0.000	-	0.002	
b	0.23	0.30	0.41	0.009	0.012	0.016	
С	0.23	0.28	0.33	0.009	0.011	0.013	
D	3.20	3.30	3.40	0.126	0.130	0.134	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
D3	0.48	=	0.89	0.019	-	0.035	
D4		0.47 typ.			0.0185 typ		
D5	2.3 typ.				0.090 typ		
E	3.20	3.30	3.40	0.126	0.130	0.134	
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	1.75	1.85	1.98	0.069	0.073	0.078	
E4	0.034 typ.				0.013 typ.		
е	0.65 BSC 0.026 BSC						
K		0.86 typ.			0.034 typ.		
K1	0.35	=	-	0.014	-	-	
Н	0.30	0.41	0.51	0.012	0.016	0.020	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
θ	0°	-	12°	0°	-	12°	
W	0.15	0.25	0.36	0.006	0.010	0.014	
М		0.125 typ.	•		0.005 typ.		

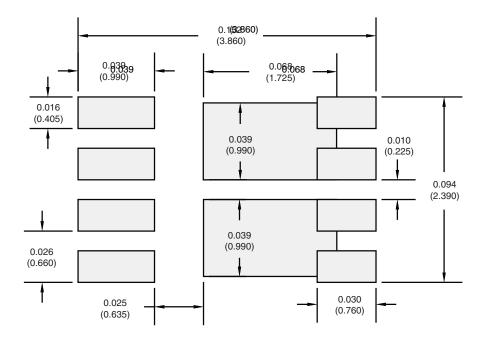
ECN: S16-2667-Rev. M, 09-Jan-17

DWG: 5882



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#### **RECOMMENDED MINIMUM PADS FOR DFN 3x3 Dual**



Recommended Minimum PADs for PowerPAK 1212-8 Dual Dimensions in Inches/(mm)



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